

<b>Notice of References Cited</b>	Application/Control No. 10/655,223		Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner Minh Trinh		Art Unit 3729	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,915,566	07-2005	Abbott et al.	29/852
*	B	US-6,852,625	02-2005	Shin et al.	438/678
*	C	US-6,574,858	06-2003	Hembree, David R.	29/827
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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